# PHK28NQ03LT

## N-channel TrenchMOS logic level FET

Rev. 03 — 8 December 2009 Product data sheet

## 1. Product profile

### 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

### 1.2 Features and benefits

- Simple gate drive required due to low gate charge
- Suitable for logic level gate drive sources

### 1.3 Applications

- DC-to-DC convertors
- Switched-mode power supplies

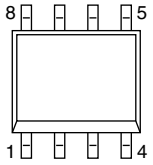
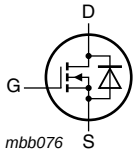
### 1.4 Quick reference data

**Table 1. Quick reference**

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|
| $V_{DS}$ | drain-source voltage | $T_j \geq 25$ °C; $T_j \leq 150$ °C | - | - | 30 | V |
| $I_D$ | drain current | $T_{sp} = 25$ °C; $V_{GS} = 10$ V; see Figure 1 and 3 | - | - | 23.7 | A |
| $P_{tot}$ | total power dissipation | $T_{sp} = 25$ °C; see Figure 2 | - | - | 6.25 | W |
| **Dynamic characteristics** | | | | | | |
| $Q_{GD}$ | gate-drain charge | $V_{GS} = 4.5$ V; $I_D = 14$ A; $V_{DS} = 15$ V; $T_j = 25$ °C; see Figure 11 | - | 11.4 | - | nC |
| **Static characteristics** | | | | | | |
| $R_{DSon}$ | drain-source on-state resistance | $V_{GS} = 10$ V; $I_D = 14$ A; $T_j = 25$ °C; see Figure 9 and 10 | - | 5.5 | 6.5 | mΩ |

## 2. Pinning information

**Table 2. Pinning information**

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|---|---|---|---|---|
| 1 | S | source |  |  |
| 2 | S | source | | |
| 3 | S | source | | |
| 4 | G | gate | | |
| 5 | D | drain | | |
| 6 | D | drain | SOT96-1 (SO8) | |
| 7 | D | drain | | |
| 8 | D | drain | | |



## 3. Ordering information

**Table 3. Ordering information**

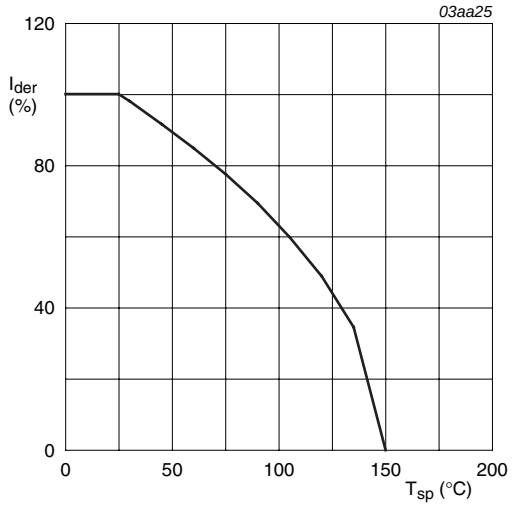
| Type number | Package | | |
|---|---|---|---|
| | Name | Description | Version |
| PHK28NQ03LT | SO8 | plastic small outline package; 8 leads; body width 3.9 mm | SOT96-1 |

## 4. Limiting values

**Table 4. Limiting values**

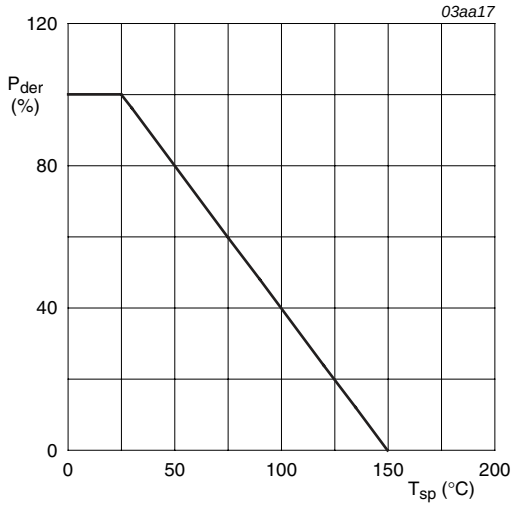
*In accordance with the Absolute Maximum Rating System (IEC 60134).*

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---|---|---|---|---|---|
| $V_{DS}$ | drain-source voltage | $T_j \geq 25$ °C; $T_j \leq 150$ °C | - | 30 | V |
| $V_{DGR}$ | drain-gate voltage | $T_j \leq 150$ °C; $T_j \geq 25$ °C; $R_{GS} = 20$ kΩ | - | 30 | V |
| $V_{GS}$ | gate-source voltage | | - | 20 | V |
| $I_D$ | limiting drain current | $T_{sp} = 100$ °C; $V_{GS} = 10$ V; see Figure 1 | - | 15 | A |
| | drain current | $T_{sp} = 25$ °C; $V_{GS} = 10$ V; see Figure 1 and 3 | - | 23.7 | A |
| $I_{DM}$ | peak drain current | $T_{sp} = 25$ °C; $t_p \leq 10$ µs; pulsed; see Figure 3 | - | 60 | A |
| $P_{tot}$ | total power dissipation | $T_{sp} = 25$ °C; see Figure 2 | - | 6.25 | W |
| $T_{stg}$ | storage temperature | | -55 | 150 | °C |
| $T_j$ | junction temperature | | -55 | 150 | °C |
| **Source-drain diode** | | | | | |
| $I_S$ | source current | $T_{sp} = 25$ °C | - | 5.2 | A |
| $I_{SM}$ | peak source current | $T_{sp} = 25$ °C; $t_p \leq 10$ µs; pulsed | - | 20.8 | A |



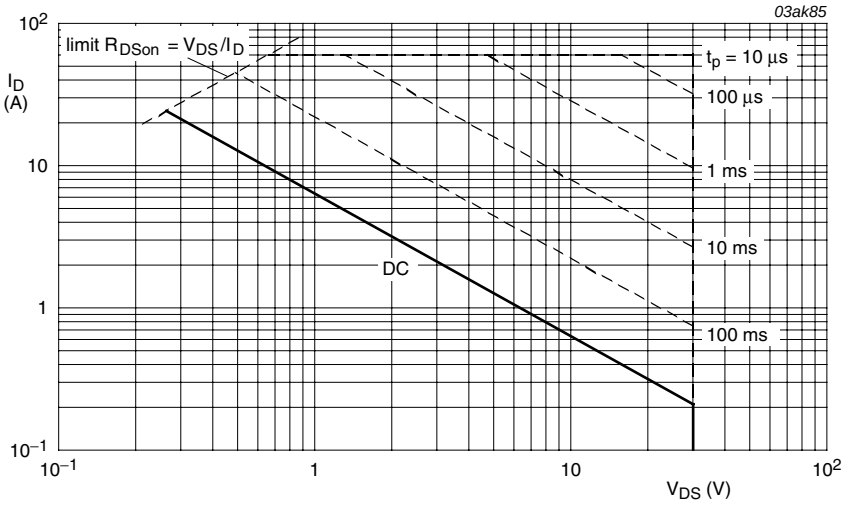

$$I_{der} = \frac{I_D}{I_{D(25°C)}} \times 100\,\%$$

**Fig 1. Normalized continuous drain current as a function of solder point temperature**




$$P_{der} = \frac{P_{tot}}{P_{tot(25°C)}} \times 100\,\%$$

**Fig 2. Normalized total power dissipation as a function of solder point temperature**




$$T_{sp} = 25°C; I_{DM} \text{ is single pulse}; V_{GS} = 10V$$

**Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage**

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|
| $R_{th(j\text{-}sp)}$ | thermal resistance from junction to solder point | see Figure 4 | - | - | 20 | K/W |

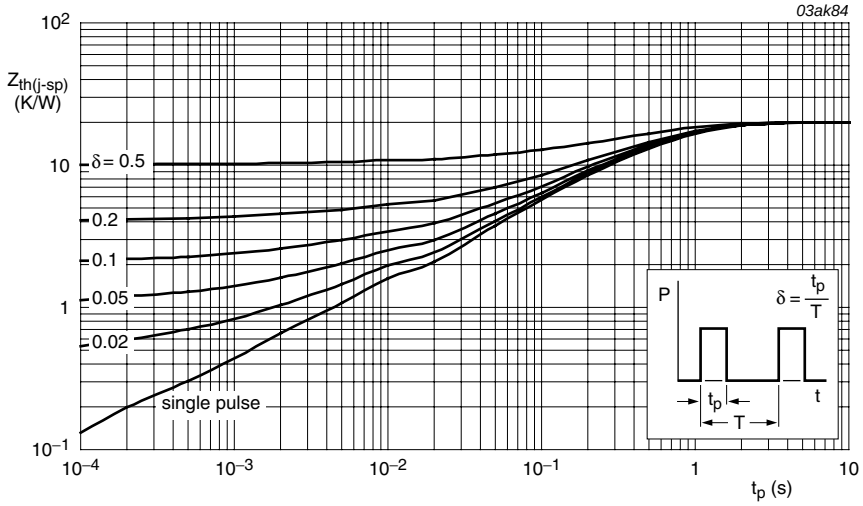
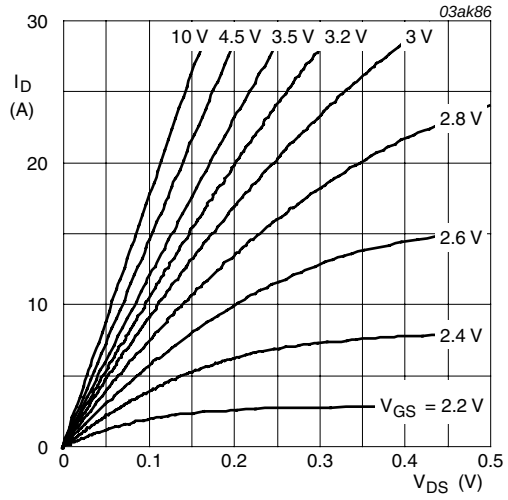



**Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration**

## 6. Characteristics

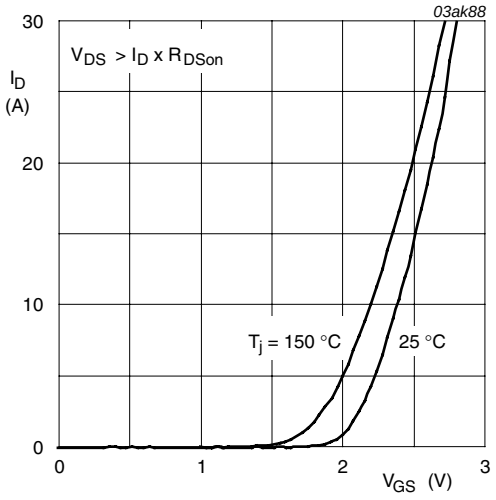
**Table 6. Characteristics**

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|
| **Static characteristics** | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = 25 °C | 30 | - | - | V |
| | | $I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = -55 °C | 27 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D$ = 1 mA; $V_{DS}$= $V_{GS}$; $T_j$ = 150 °C; see Figure 8 | 0.6 | - | - | V |
| | | $I_D$ = 1 mA; $V_{DS}$= $V_{GS}$; $T_j$ = -55 °C; see Figure 8 | - | - | 2.2 | V |
| | | $I_D$ = 1 mA; $V_{DS}$= $V_{GS}$; $T_j$ = 25 °C; see Figure 8 | 1 | 1.5 | 2 | V |
| $I_{DSS}$ | drain leakage current | $V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 150 °C | - | - | 500 | µA |
| | | $V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C | - | 0.05 | 1 | µA |
| $I_{GSS}$ | gate leakage current | $V_{GS}$ = 16 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C | - | 10 | 100 | nA |
| | | $V_{GS}$ = -16 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C | - | 10 | 100 | nA |
| $R_{DSon}$ | drain-source on-state resistance | $V_{GS}$ = 4.5 V; $I_D$ = 13 A; $T_j$ = 150 °C; see Figure 9 and 10 | - | 11.2 | 13.1 | mΩ |
| | | $V_{GS}$ = 10 V; $I_D$ = 14 A; $T_j$ = 25 °C; see Figure 9 and 10 | - | 5.5 | 6.5 | mΩ |
| | | $V_{GS}$ = 4.5 V; $I_D$ = 13 A; $T_j$ = 25 °C; see Figure 9 and 10 | - | 6.6 | 7.7 | mΩ |
| **Dynamic characteristics** | | | | | | |
| $Q_{G(tot)}$ | total gate charge | $I_D$ = 14 A; $V_{DS}$ = 15 V; $V_{GS}$ = 4.5 V; $T_j$ = 25 °C; see Figure 11 | - | 30.3 | - | nC |
| $Q_{GS}$ | gate-source charge | | - | 7.8 | - | nC |
| $Q_{GD}$ | gate-drain charge | | - | 11.4 | - | nC |
| $C_{iss}$ | input capacitance | $V_{DS}$ = 20 V; $V_{GS}$ = 0 V; f = 1 MHz; $T_j$ = 25 °C; see Figure 12 | - | 2800 | - | pF |
| $C_{oss}$ | output capacitance | | - | 670 | - | pF |
| $C_{rss}$ | reverse transfer capacitance | | - | 320 | - | pF |
| $t_{d(on)}$ | turn-on delay time | $V_{DS}$ = 15 V; $R_L$ = 15 Ω; $V_{GS}$ = 10 V; $R_{G(ext)}$ = 6 Ω; $T_j$ = 25 °C | - | 11 | - | ns |
| $t_r$ | rise time | | - | 10 | - | ns |
| $t_{d(off)}$ | turn-off delay time | | - | 80 | - | ns |
| $t_f$ | fall time | | - | 40 | - | ns |
| **Source-drain diode** | | | | | | |
| $V_{SD}$ | source-drain voltage | $I_S$ = 2.3 A; $V_{GS}$ = 0 V; $T_j$ = 25 °C; see Figure 13 | - | 0.72 | 1.2 | V |



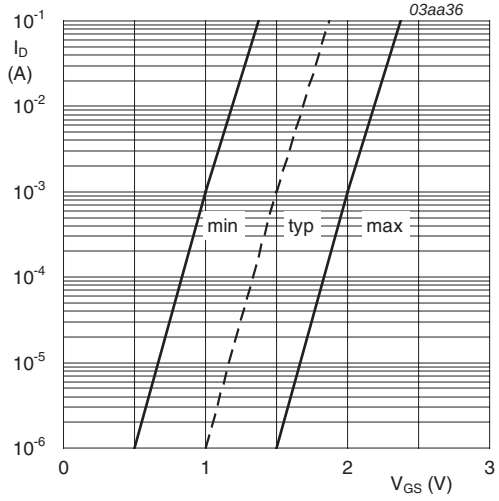

$T_j = 25°C$

**Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values**



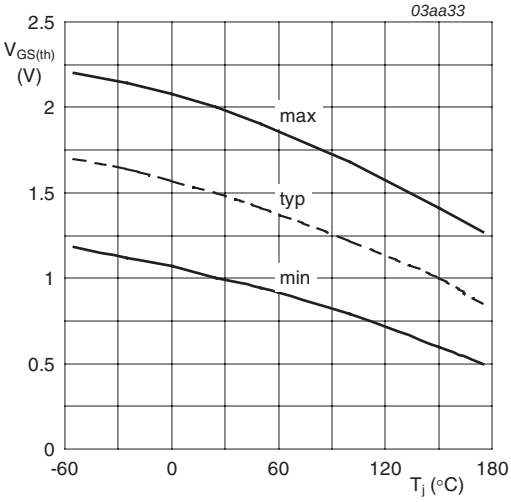

$T_j = 25°C \text{ and } 150°C; V_{DS} > I_D \times R_{DSon}$

**Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values**



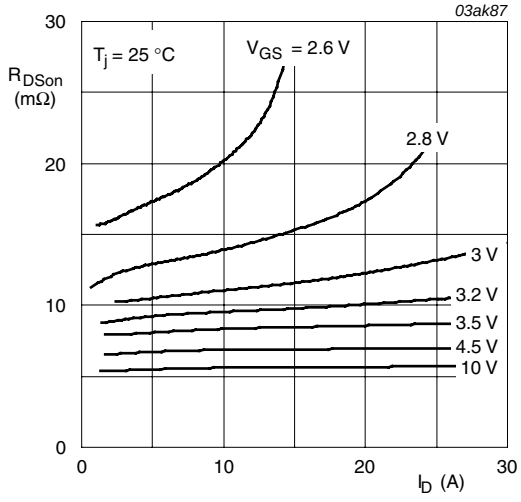

$T_j = 25\,°C; V_{DS} = V_{GS}$

**Fig 7. Sub-threshold drain current as a function of gate-source voltage**



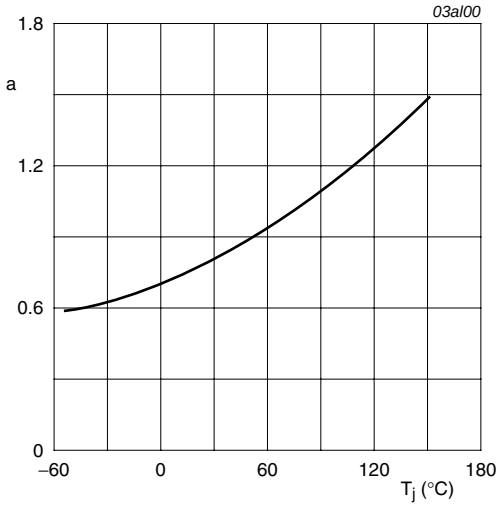

$I_D = 1\,mA; V_{DS} = V_{GS}$

**Fig 8. Gate-source threshold voltage as a function of junction temperature**



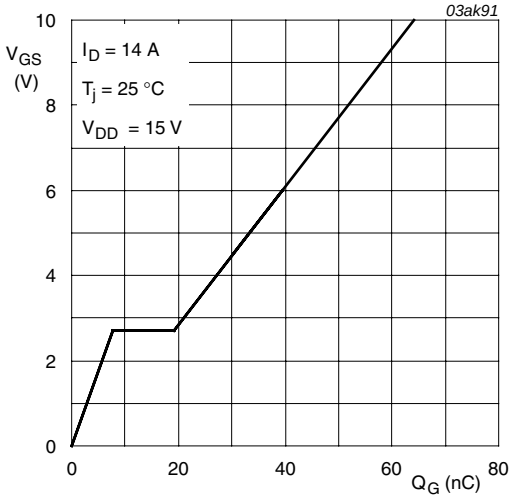

$T_j = 25°C$

**Fig 9. Drain-source on-state resistance as a function of drain current; typical values**



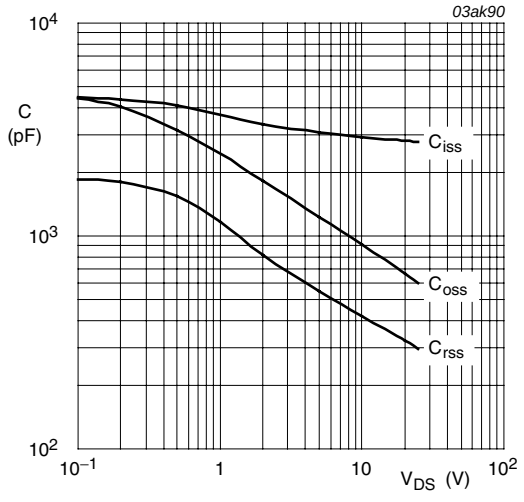

$$a = \frac{R_{DSon}}{R_{DSon(25°C)}}$$

**Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature**



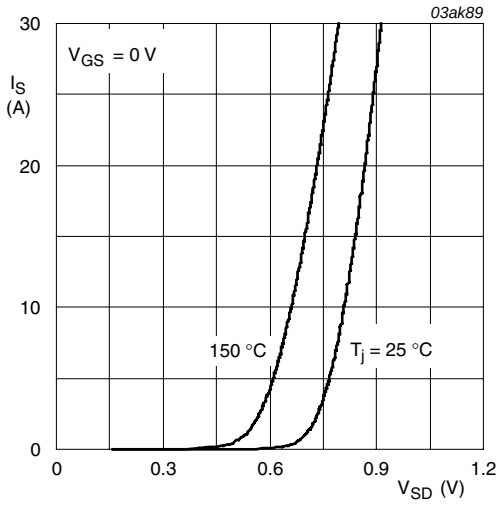

$I_D = 14A; V_{DD} = 15V$

**Fig 11. Gate-source voltage as a function of gate charge; typical values**




$V_{GS} = 0V; f = 1MHz$

**Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**

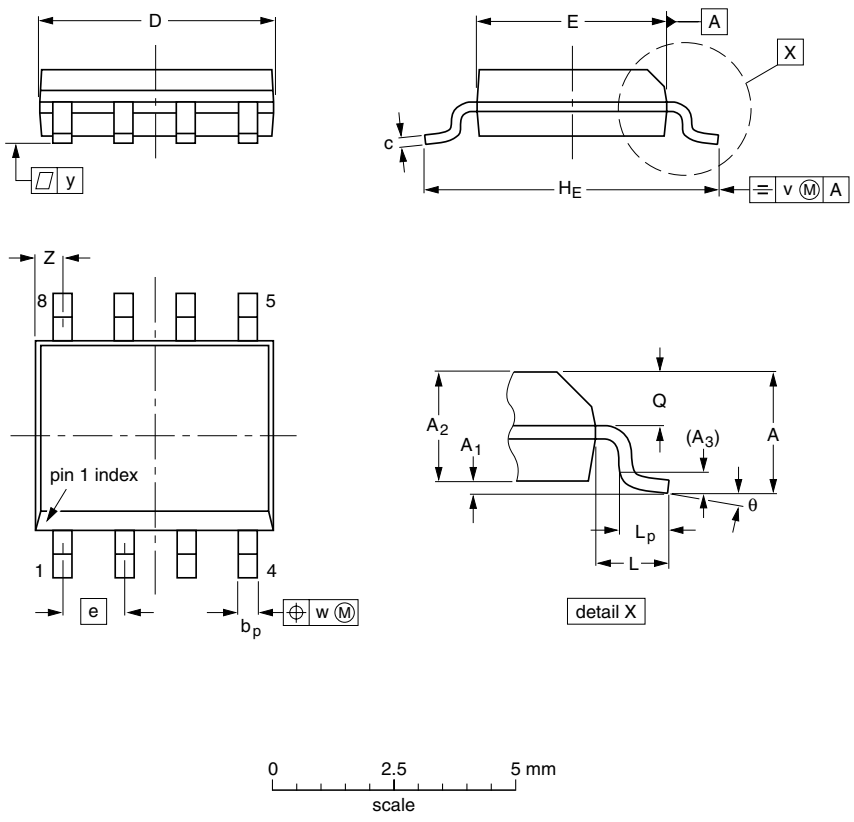



$T_j = 25°C \text{ and } 150°C; V_{GS} = 0V$

**Fig 13. Source current as a function of source-drain voltage; typical values**

# 7. Package outline

**SO8: plastic small outline package; 8 leads; body width 3.9 mm** **SOT96-1**




**DIMENSIONS (inch dimensions are derived from the original mm dimensions)**

| UNIT | A max. | $A_1$ | $A_2$ | $A_3$ | $b_p$ | c | $D^{(1)}$ | $E^{(2)}$ | e | $H_E$ | L | $L_p$ | Q | v | w | y | $Z^{(1)}$ | θ |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| mm | 1.75 | 0.25<br>0.10 | 1.45<br>1.25 | 0.25 | 0.49<br>0.36 | 0.25<br>0.19 | 5.0<br>4.8 | 4.0<br>3.8 | 1.27 | 6.2<br>5.8 | 1.05 | 1.0<br>0.4 | 0.7<br>0.6 | 0.25 | 0.25 | 0.1 | 0.7<br>0.3 | $8^o$<br>$0^o$ |
| inches | 0.069 | 0.010<br>0.004 | 0.057<br>0.049 | 0.01 | 0.019<br>0.014 | 0.0100<br>0.0075 | 0.20<br>0.19 | 0.16<br>0.15 | 0.05 | 0.244<br>0.228 | 0.041 | 0.039<br>0.016 | 0.028<br>0.024 | 0.01 | 0.01 | 0.004 | 0.028<br>0.012 | |

**Notes**

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|---|---|---|---|---|---|---|
| | IEC | JEDEC | JEITA | | | |
| SOT96-1 | 076E03 | MS-012 | | | | ~~99-12-27~~<br>03-02-18 |

**Fig 14. Package outline SOT96-1 (SO8)**

## 8. Revision history

**Table 7. Revision history**

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|---|---|---|---|---|
| PHK28NQ03LT_3 | 20091208 | Product data sheet | - | PHK28NQ03LT-02 |
| Modifications: | • The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.<br>• Legal texts have been adapted to the new company name where appropriate. | | | |
| PHK28NQ03LT-02 (9397 750 11367) | 20030410 | Product data | - | PHK28NQ03LT-01 |
| PHK28NQ03LT-01 (9397 750 10743) | 20021212 | Product data | - | - |

# 9. Legal information

## 9.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|---|---|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URLhttp://www.nxp.com.

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# 10. Contact information

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## 11. Contents





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**Document identifier: PHK28NQ03LT_3**

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